## Notice of References Cited Application/Control No. 10/563,299 Applicant(s)/Patent Under Reexamination YOSHIDA ET AL. Examiner John Freeman Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,314,561 A	05-1994	Komiya, Yuji	156/244.11
*	В	US-5,427,235 A	06-1995	Powell et al.	206/245
*	С	US-5,667,886 A	09-1997	Gough et al.	428/331
*	D	US-5,683,534 A	11-1997	Lofgren et al.	156/231
*	Е	US-6,013,363 A	01-2000	Takahashi et al.	428/315.9
*	F	US-2002/0009564 A1	01-2002	Hall et al.	428/35.7
*	G	US-2002/0061959 A1	05-2002	Kajimaru et al.	524/601
*	Η	US-2005/0208282 A1	09-2005	Wood et al.	428/216
*	I	US-2006/0141244 A1	06-2006	Hatada, Kenji	428/336
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP2002036422	02-2002	Japan	Maekawa et al.	
	0					
	Ρ					
	σ					
	R					
	S					
	۲					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	O	Machine translation of Noboru et al. (JP 07-137192).				
	V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.